

LITES: EUV and FUV from the ISS

George Geddes¹

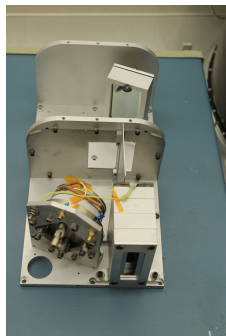
March 19, 2018

¹george_geddes@student.uml.edu

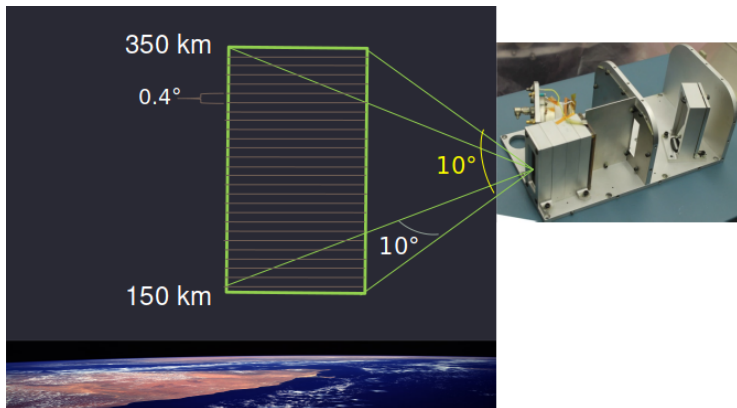
LITES

Limb-Imaging Thermospheric Extreme-ultraviolet Spectrograph

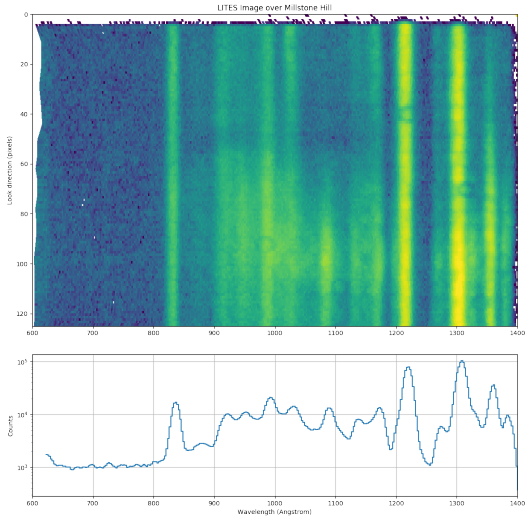
- ▶ $10^\circ \times 10^\circ$ field of view
- ▶ 150 - 350 km line-of-sight tangent altitude
- ▶ 140 - 60 nm spectrum
- ▶ Aft viewing from the ISS ($\simeq 410$ km)
- ▶ Launched March 2016
- ▶ Began operations April 2016



LITES Viewing Geometry

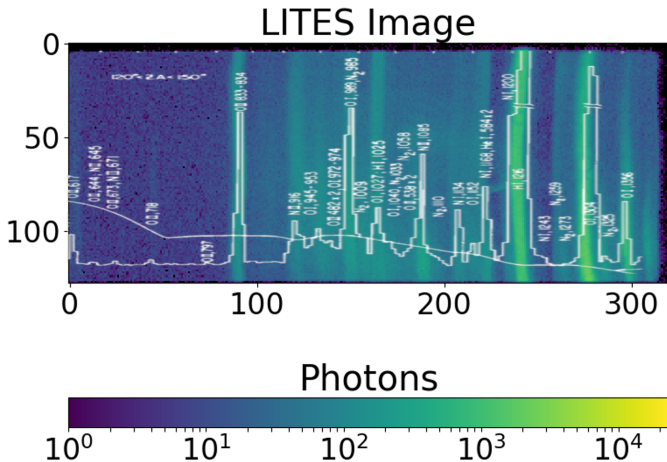


LITES Spectral Image



Features

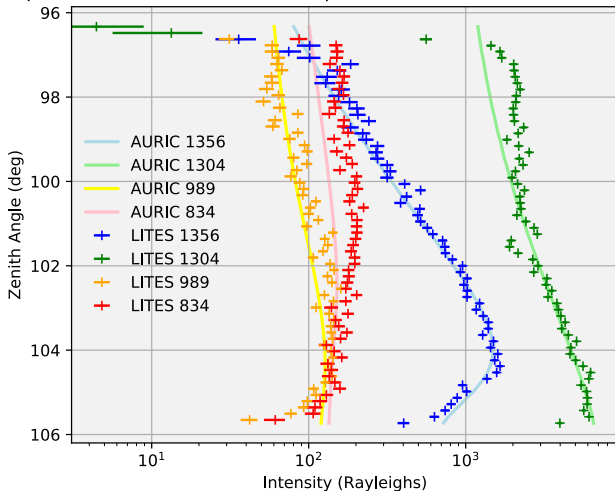
Tons of O O_2 , and N_2 features.



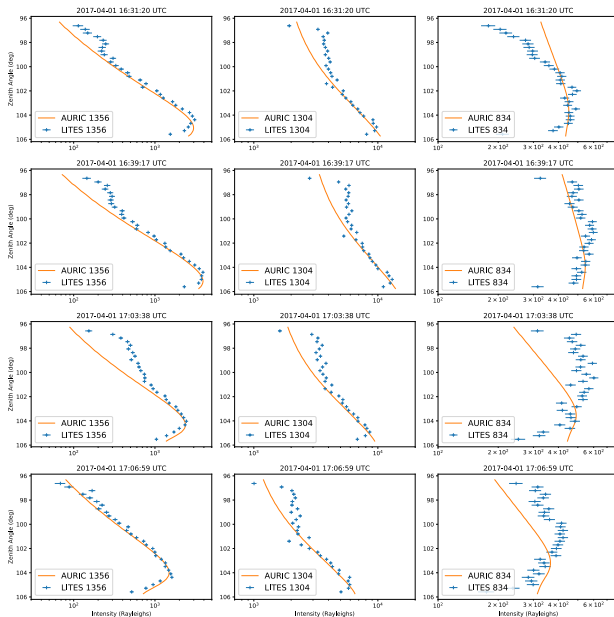
Comparison of LITES image and Chakrabarti et al. (1984).

Limb Profiles

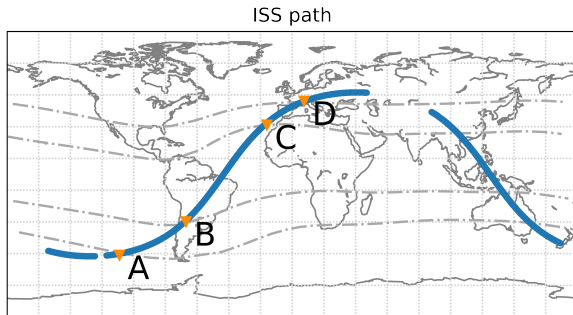
Comparison of LITES limb to AURIC prediction for 2017-04-01 17:06:59 UTC



More Limb Profiles



Map

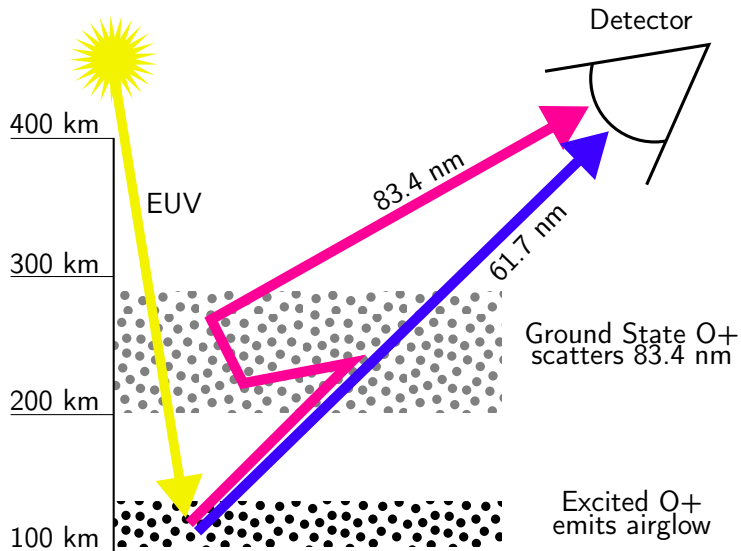


Locations for the profiles on the previous slide.

Orbit Movie

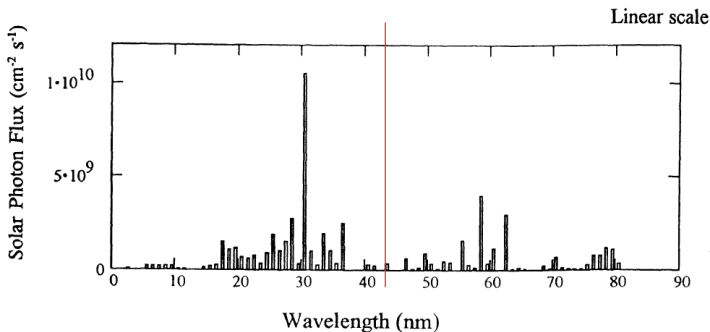
Open Movie. . .

OII Dayglow



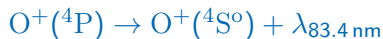
Excitation

- ▶ Excited by solar EUV photons < 43.6 nm
- ▶ Main contribution from He 30.4 nm

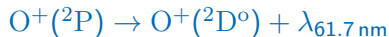


SOHO solar EUV spectrum Judge et al. [1998].

Emission Processes

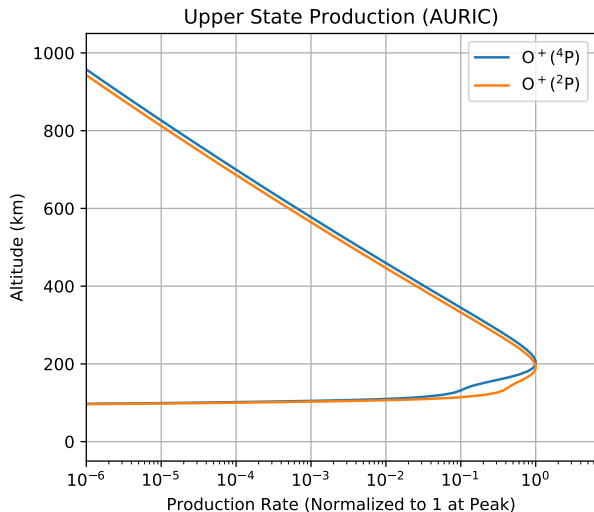


- ▶ Final state is ground state O^+
- ▶ Optically thick ($1 \lesssim \tau \lesssim 10$)
- ▶ Brightness $\sim 1 \text{ kR}$



- ▶ Final state is forbidden from ground state
- ▶ Optically thin
- ▶ Brightness $\sim 100 \text{ R}$

Similar Production



Combining Observations

- ▶ Both emissions are produced by (almost) same solar EUV
- ▶ But O II 83.4 nm has O^+ information from multiple scattering
- ▶ We can use this!

O⁺ Retrieval

By comparing **optically thick** and **optically thin** observations, we can fit an O⁺ density with few nuisance parameters.

O⁺ Retrieval

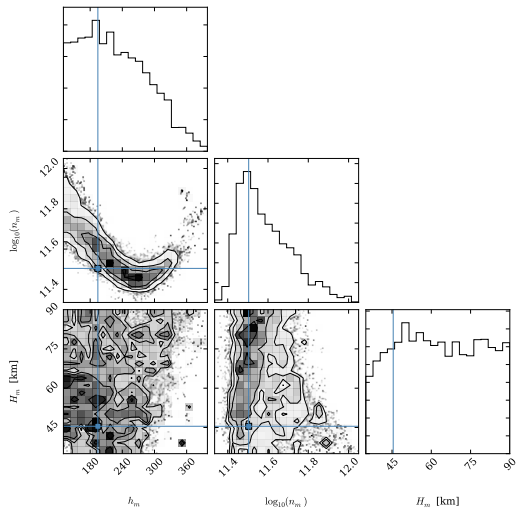
By comparing **optically thick** and **optically thin** observations, we can fit an O⁺ density with few nuisance parameters.

Procedure

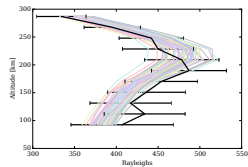
1. Make an O II 83.4 nm limb observation
2. Model a thermosphere, ionosphere, and solar EUV
3. Check fit to data
4. Tweak ionosphere parameters and model again
5. Repeat 2-4 until we get a satisfactory fit

Monte Carlo Results

15 January 2010



Geddes et al. [2016]



Geddes et al. [2016]

Uncertainties

This procedure doesn't take systematic uncertainties in the model or instrument into account.

Picone et al. [1997] introduce an overall scale parameter to remedy this.

Scale Parameter

An overall scale parameter is the simplest model we can use to account for systematic errors (in the model or instrument)
The scale factor accounts for uncertainty in instrument calibration, [O], and solar EUV irradiance.

Using OII 61.7

Adding O II 61.7 nm adds a new parameter and is insensitive to the others, so how can this help?

Using OII 61.7

Adding O II 61.7 nm adds a new parameter and is insensitive to the others, so how can this help?

Bayesian Prior Probability

Instrument degradation and the small solar EUV difference are the only sources of variance between the two scale factors.

This means the two should be closely correlated.

We can impose this constraint on our fit using a prior.

Another Possibility

Limb emissions:

$$I_{83.4} = V_{83.4} M j_{83.4}$$

$$I_{61.7} = V_{61.7} j_{61.7}$$

Suppose T transforms the 61.7 nm source into the 83.4 nm source.

$$I_{83.4} = V_{83.4} M T V_{61.7}^{-1} I_{61.7}$$

- ▶ T is *almost* a simple scaling.
- ▶ Subtract l.h.s from r.h.s and we get a new r.v. that looks like a volume emission rate of something.
- ▶ This method separates systematic errors in calibration and neutral density from errors in solar EUV.
- ▶ Doing this would introduce yet another fit parameter which accounts for solar EUV, but systematic errors from different sources are more isolated

$$M^{-1}V_8^{-1}\eta_8l_8 - TV_6^{-1}\eta_6l_6 = r$$

- ▶ r "residual" emission
- ▶ Estimate r using a model and iterate over parameters to fit
- ▶ With a Markov chain scattering model, M^{-1} is cheaper to compute

Markov Chain Scattering Model



- ▶ A photon scattering through the F2 layer is a Markov process.
- ▶ Multiply scattered profile is a geometric series in the single-scattering probability (Q) [Vickers, 1996]

$$\begin{aligned} M &= 1 + Q + Q^2 + Q^3 + \dots \\ &= (1 - Q)^{-1} \end{aligned}$$

References

- George Geddes, Ewan Douglas, Susanna C Finn, Timothy Cook, and Supriya Chakrabarti. Inverting OII 83.4 nm dayglow profiles using markov chain radiative transfer. *Journal of Geophysical Research: Space Physics*, 121(11), 2016.
- DL Judge, DR McMullin, HS Ogawa, D Hovestadt, B Klecker, M Hilchenbach, E Möbius, LR Canfield, RE Vest, R Watts, et al. First solar euv irradiances obtained from soho by the celiass/sem. In *Solar Electromagnetic Radiation Study for Solar Cycle 22*, pages 161–173. Springer, 1998.
- J. M. Picone, R. R. Meier, O. A. Kelley, D. J. Melendez-Alvira, K. F. Dymond, R. P. McCoy, and Michael J. Buonsanto. Discrete inverse theory for 834-Å ionospheric remote sensing. *Radio Science*, 32(5):1973–1984, 1997. ISSN 1944-799X. doi: 10.1029/97RS01028. URL <https://doi.org/10.1029/97RS01028>.
- Andrew W Stephan. Advances in remote sensing of the daytime ionosphere with euv airglow. *Journal of Geophysical Research: Space Physics*, 2016.
- DJ Strickland, J Bishop, JS Evans, T Majeed, PM Shen, RJ Cox, R Link, and RE Huffman. Atmospheric ultraviolet radiance integrated code (AURIC): Theory, software architecture, inputs, and selected results. *Journal of Quantitative Spectroscopy and Radiative Transfer*, 62(6):689–742, 1999.
- James Squire Vickers. *An Evaluation of EUV Remote Sensing of the Ionosphere using the O-II 834-Å emission*. PhD thesis, UC Berkeley, 1996.